Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2022
Based on structural similarity

Supplier	**User Part Number**
Nexperia B.V.	74AHCU04PW-Q100

Part Description: Hex inverter; unbuffered

Function Family: AHC(T)
Process family: Super micron
Package family: TSSOP

JESD47	Test	Test Conditions	Duration	# Lots	# Quantity	# Rejects
# 1	**TEST** Pre- and Post-Stress Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below
# 2	**PC** Preconditioning	JESD22-A113 MSL 1	N/A	1070	83683	0
# 5a	**HTOL EFR** High Temperature Operating Life Extrinsic	JESD22-A108 Tj = 150°C $V_{CCMAX} \leq V \leq 1.2*V_{CCMAX}$	48 hours or 168 hours	136	39090	0
# 5b	**HTOL IFR** High Temperature Operating Life Intrinsic	JESD22-A108 Tj = 150°C $V_{CCMAX} \leq V \leq 1.2*V_{CCMAX}$	≥500 hours	84	5695	0
# 7	**TC** Temperature Cycling	JESD22-A104 -65 °C to 150°C	≥500 cycles	549	43127	0
# 9	**uHAST / HAST** unbiased or biased High Accelerated Stress Test	JESD22-A101 Tamb = 130 °C, RH = 85%, V = V_{CCMAX}	96 hours	521	40556	0

Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above)
Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)
Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Product Family	Package Family	Quantity	Rejects	Extrinsic Failure Rate (PPM)	Intrinsic Failure Rate (FIT)	MTTF (hrs)
AHC(T)	TSSOP	5695	0	24	0.6	1.74 E+09

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